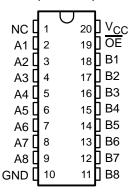
- Functionally Equivalent to QS3245
- Standard '245-Type Pinout
- 5-Ω Switch Connection Between Two Ports
- TTL-Compatible Control Input Levels
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Quarter-Size Small-Outline (DBQ), Thin Very Small-Outline (DGV), and Thin Shrink Small-Outline (PW) Packages

description

The SN74CBT3245A provides eight bits of high-speed TTL-compatible bus switching in a standard '245 device pinout. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

DB, DBQ, DGV, DW, OR PW PACKAGE (TOP VIEW)



NC - No internal connection

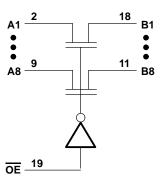
The device is organized as one 8-bit switch. When output enable (\overline{OE}) is low, the switch is on and port A is connected to port B. When \overline{OE} is high, the switch is open and a high-impedance state exists between the two ports.

The SN74CBT3245A is characterized for operation from -40°C to 85°C.

FUNCTION TABLE

INPUT OE	INPUTS/ OUTPUTS		
UE UE	A, B		
L	A = B		
Н	Z		

logic diagram





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SCDS002H - NOVEMBER 1992 - REVISED MARCH 1997

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}		\dots –0.5 V to 7 V
Input voltage range, V _I (see Note 1)		\dots -0.5 V to 7 V
Continuous channel current		128 mA
Input clamp current, I_{IK} ($V_{I/O} < 0$)		–50 mA
Package thermal impedance, θ_{JA} (see Note 2):	DB package	115°C/W
	DBQ package	118°C/W
	DGV package	146°C/W
	DW package	97°C/W
	PW package	128°C/W
Storage temperature range, T _{sto}		65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		MIN	MAX	UNIT
Vcc	Supply voltage	4	5.5	V
V _{IH}	High-level control input voltage	2		V
VIL	Low-level control input voltage		8.0	V
TA	Operating free-air temperature	-40	85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST COND	TEST CONDITIONS		TYP‡	MAX	UNIT
٧ıĸ		$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA				-1.2	V
II		$V_{CC} = 5.5 \text{ V},$	$V_I = 5.5 \text{ V or GND}$				±5	μΑ
Icc		$V_{CC} = 5.5 V$,	$I_{O} = 0$,	$V_I = V_{CC}$ or GND			50	μΑ
∆lcc§	Control pins	$V_{CC} = 5.5 \text{ V},$	One input at 3.4 V,	Other inputs at V _{CC} or GND			3.5	mA
Ci	Control pins	V _I = 3 V or 0				4		pF
C _{io(OFF}	=)	$V_0 = 3 \text{ V or } 0,$	OE = V _{CC}			4		pF
r _{on} ¶		$V_{CC} = 4 V$,	V _I = 2.4 V,	I _I = 15 mA				
			V _I = 0,	I _I = 64 mA		5	7	Ω
		$V_{CC} = 4.5 \text{ V}$	$V_{I} = 0,$	I _I = 30 mA		5	7	22
			V _I = 2.4 V,	I _I = 15 mA		10	15	

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

 $[\]S$ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

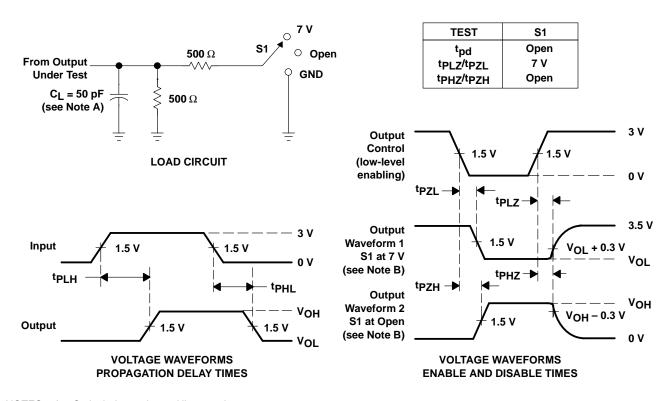
[¶] Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two (A or B) terminals.

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	AMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V ± 0.5 V		V _{CC} = 4 V		UNIT
				MIN	MAX	MIN	MAX	
t _{pd} †		A or B	B or A		0.25		0.25	ns
t _{en}		ŌĒ	A or B	1.9	5.9	2.8	6.4	ns
t _{dis}		ŌĒ	A or B	2.1	6	2.5	5.7	ns

[†] This parameter is warranted but not production tested. The propagation delay is based on the RC time constant of the typical on-state resistance of the switch and a load capacitance of 50 pF, when driven by an ideal voltage source (zero output impedance).

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_{O} = 50 \Omega$, $t_{f} \leq$ 2.5 ns, $t_{f} \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpZL and tpZH are the same as ten.
- G. tplH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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